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# Strain mapping with Polarisation-Sensitive Optical Coherence Tomography

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Material Characterization (CDL-MS-MACH)

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# Acknowledgements

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  - Austrian Federal Ministry of Economy, Family and Youth
  - National Foundation for Research, Technology and Development



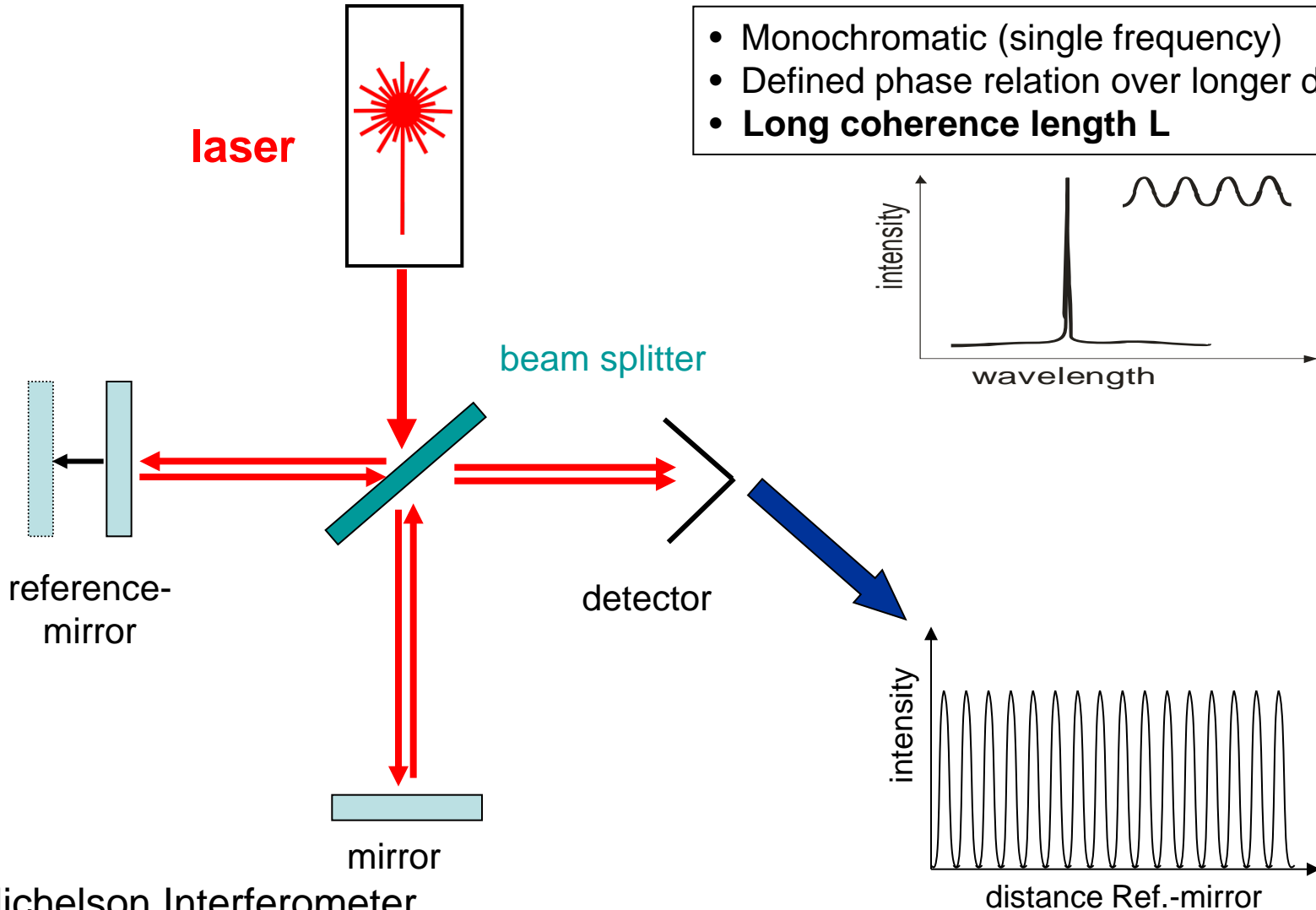
# Outline

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- Introduction to optical coherence tomography (OCT)
- Extension of OCT towards polarization-sensitive imaging (PS-OCT)
- Application of PS-OCT for strain mapping and dynamic material characterization
- Conclusion and outlook

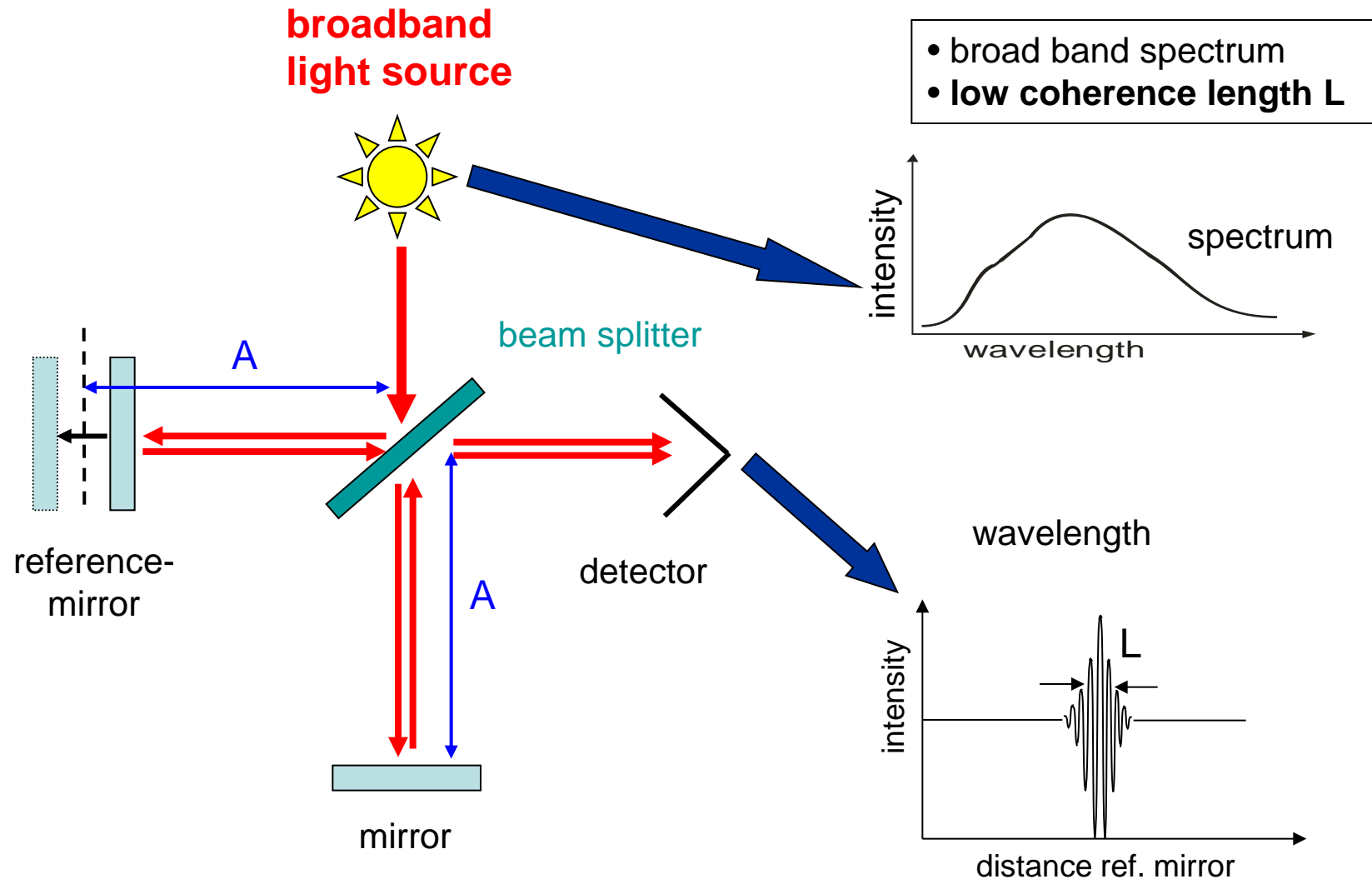
# Laser interferometry

- Monochromatic (single frequency)
- Defined phase relation over longer distances
- **Long coherence length  $L$**

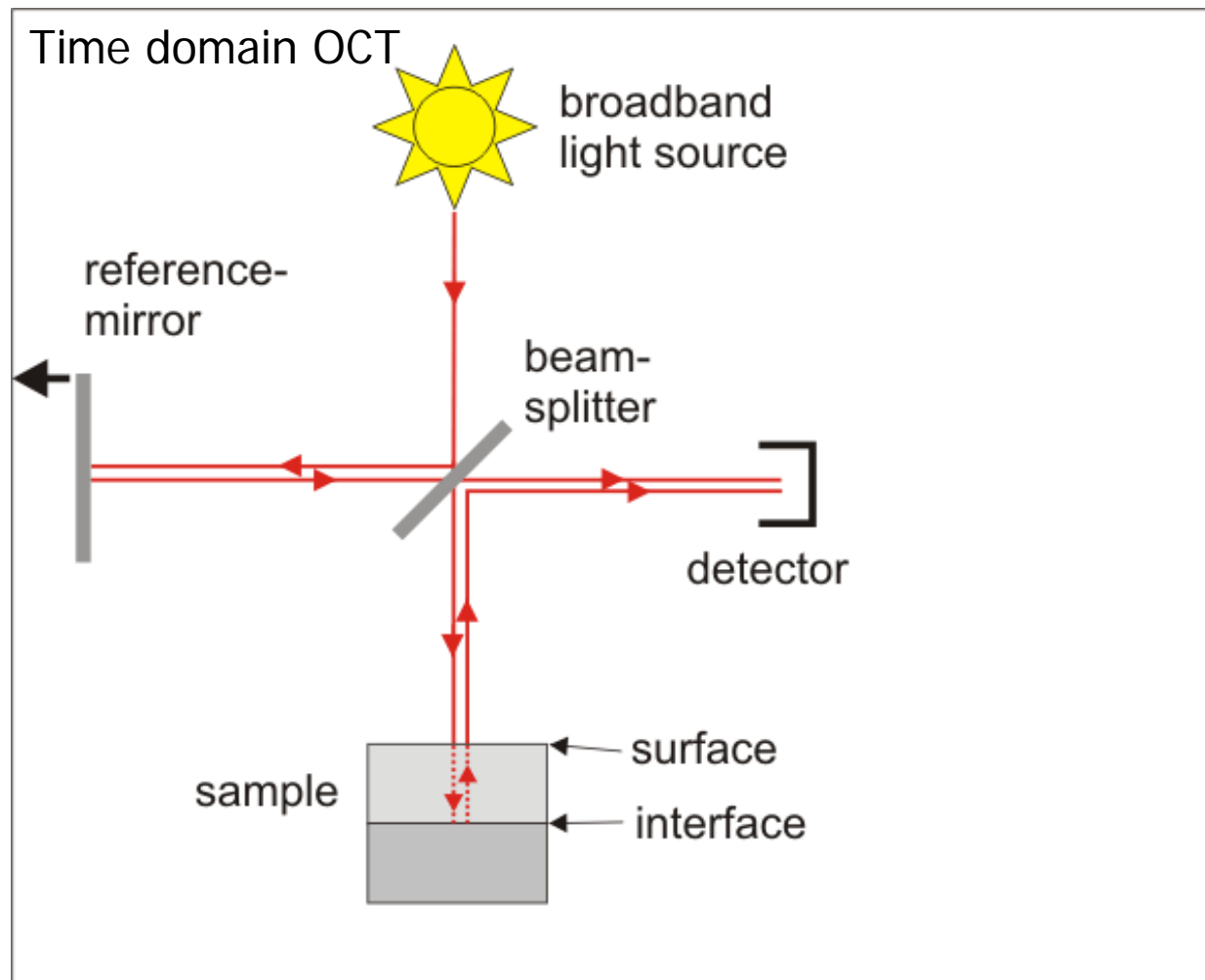


Michelson Interferometer

# White light (low coherence) interferometry (WLI/LCI)



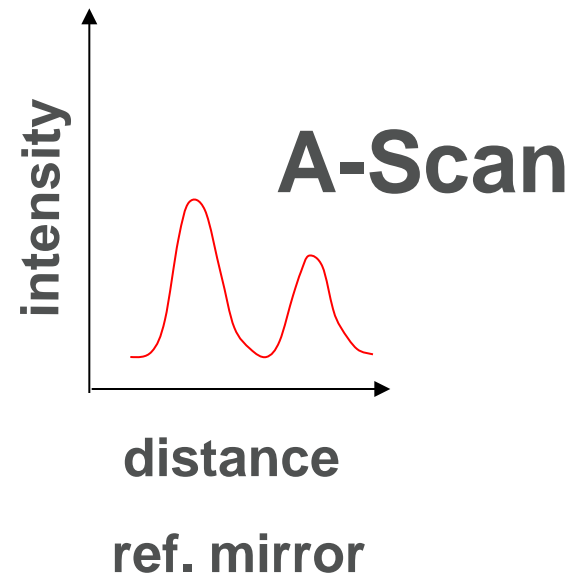
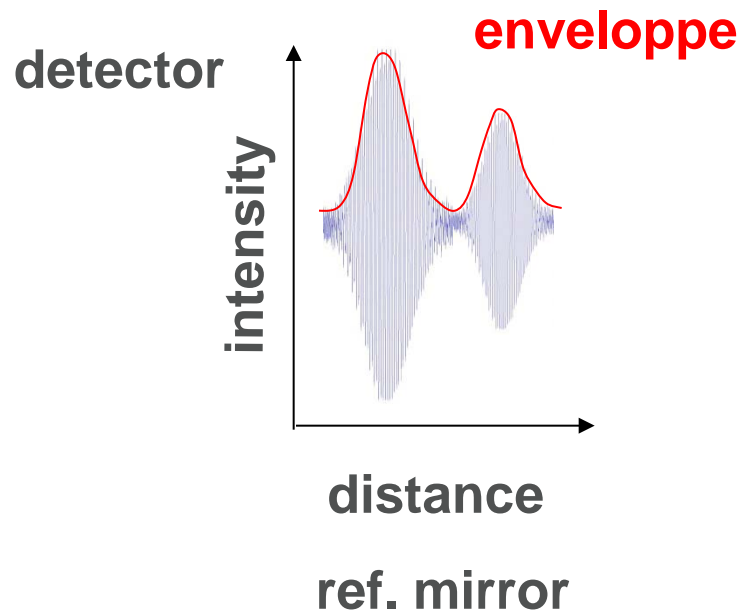
# Principle of OCT



→ D. Huang et al., Science 254, 1178 (1991)

# OCT depth profile: A-Scan

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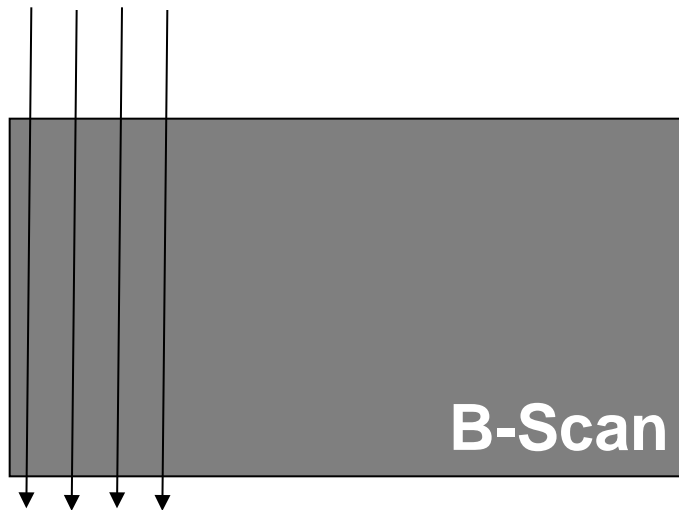


# OCT cross-section: B-Scan

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**Sequence of A-Scans leads to:  
cross-sectional image (B-scan)**

**A-Scans**



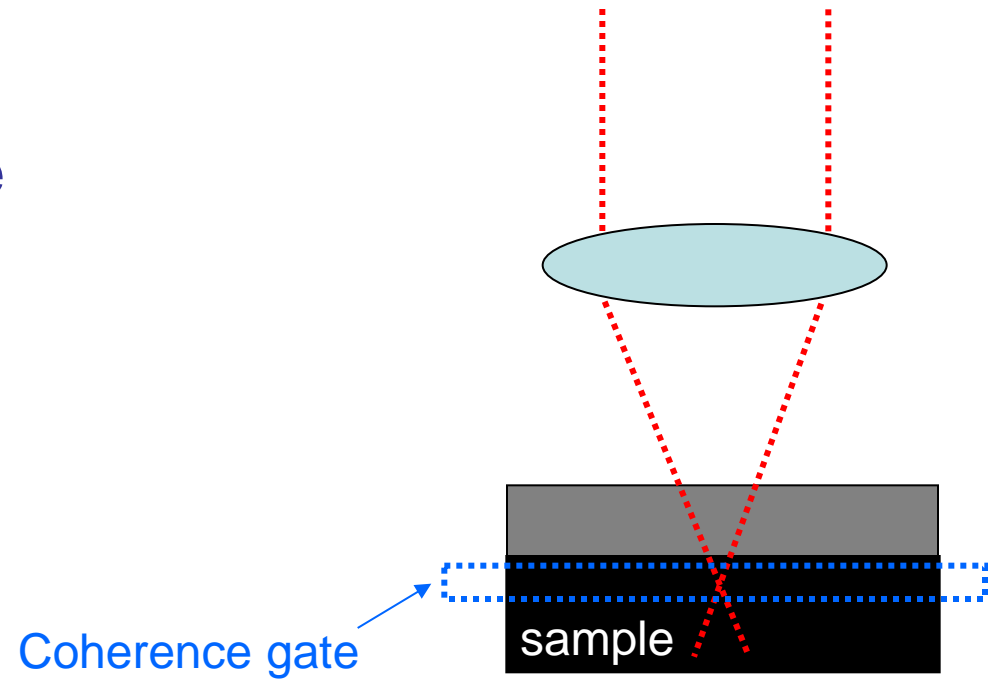


# OCT: lateral resolution

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→ decoupled from axial (depth) resolution

→ determined by spot size



# OCT depth (axial) resolution

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Axial resolution  $\delta z$  (decoupled from lateral resolution):

$$\delta z = \frac{l_c}{n_{Medium}} = \frac{2 \ln 2}{n_{Med} \pi} \frac{\lambda_c^2}{\Delta \lambda}$$

$l_c$ ...coherence length,  $\lambda_c$ ...central wavelength,  
 $\Delta \lambda$ ...spectral width,  $n$ ...refractive index

→ Demand for broadband light sources

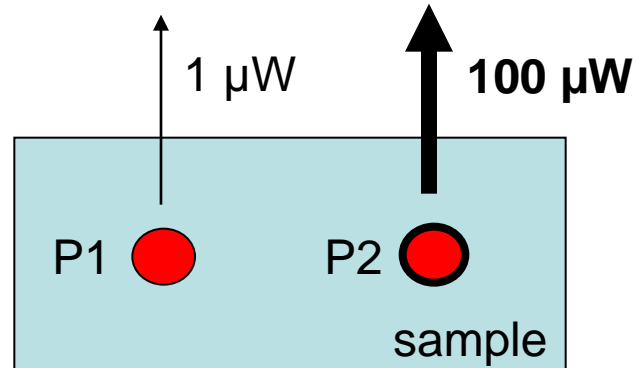
# OCT: high sensitivity

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- Incident power ~ 1 mW
- 5-15 scattering events
- High dynamic range
- High sensitivity (~100 dB, femtoWatt detectable)
- Penetration depth in scattering media ~ mm range  
(depending on wavelength and material)

# OCT: high sensitivity

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Intensity-based measurement method (e.g. fluorescence microscopy):

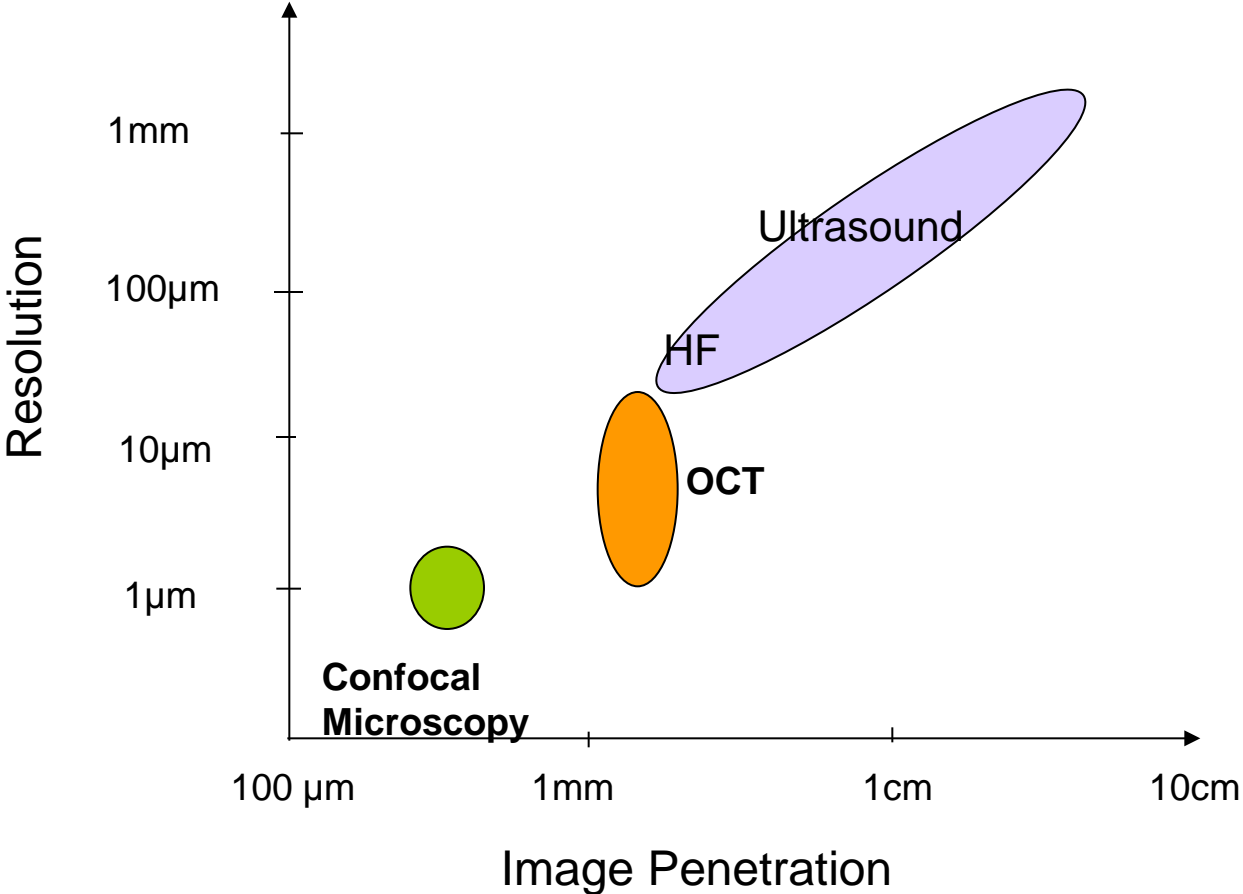
- Detector:  $P1/P2 = 1:100$

OCT:

- Signal  $\sim E_{\text{ref}} * E_{\text{sample}} \rightarrow P1/P2 = 1:10 !$
- Signal  $E_{\text{sample}}$  multiplied with reference field  $\rightarrow$  coherent amplification

# Micro-imaging techniques

Resolution vs. Image Penetration



# Origin of OCT: biomedical diagnostics

## Ophthalmology:

- ▶ Diseases of retina (glaucoma)

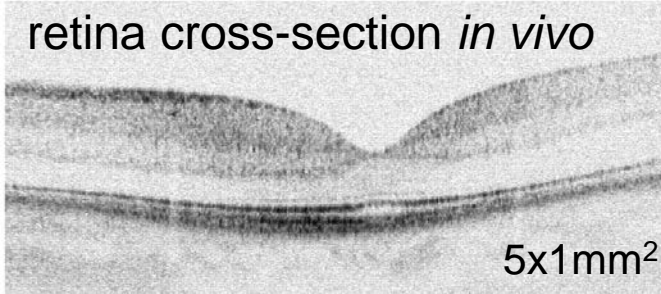
## Dermatology:

- ▶ Skin cancer, melanoma detection

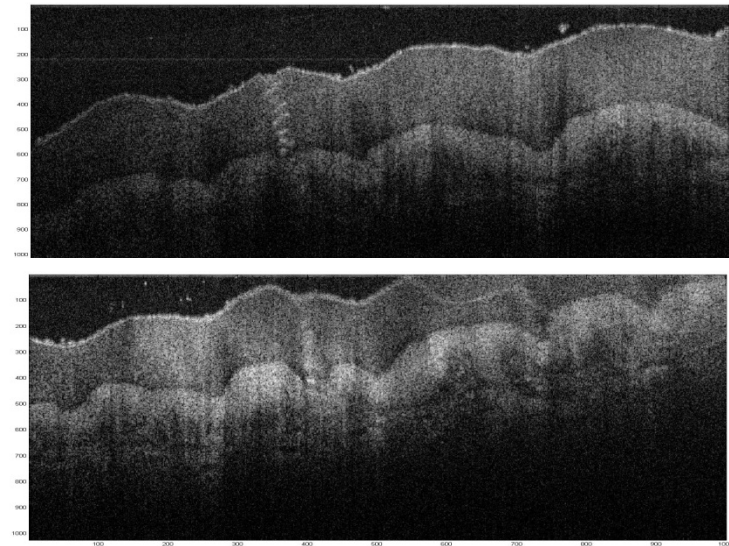
OCT:



retina cross-section *in vivo*



Pircher et. al., OPT. EXPRESS 12, 5940 (2004)

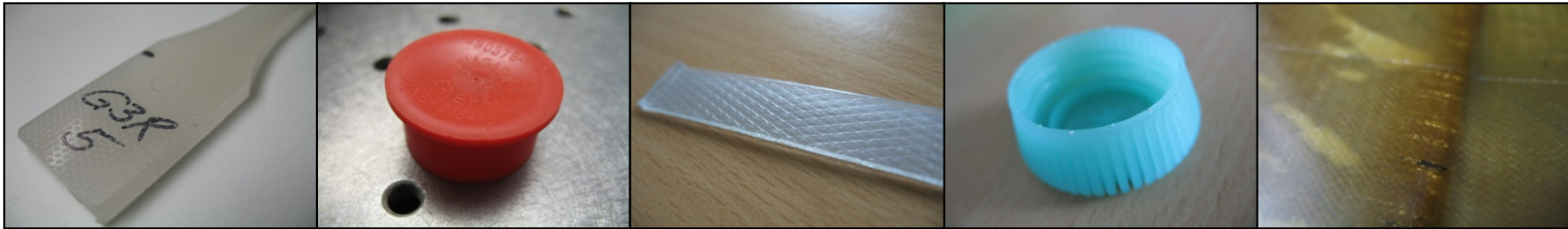


# OCT for material characterization

Main applications: **bio-medical** (retina, skin, arteries, teeth, ...)

## Material investigation?

▶ **Polymers, compound materials, ceramics, glasses...**



▶ Sizes in the range of a few microns  
(diameters of fibres, size of inclusions, thickness of layers)

→ **Ultra-high resolution OCT**

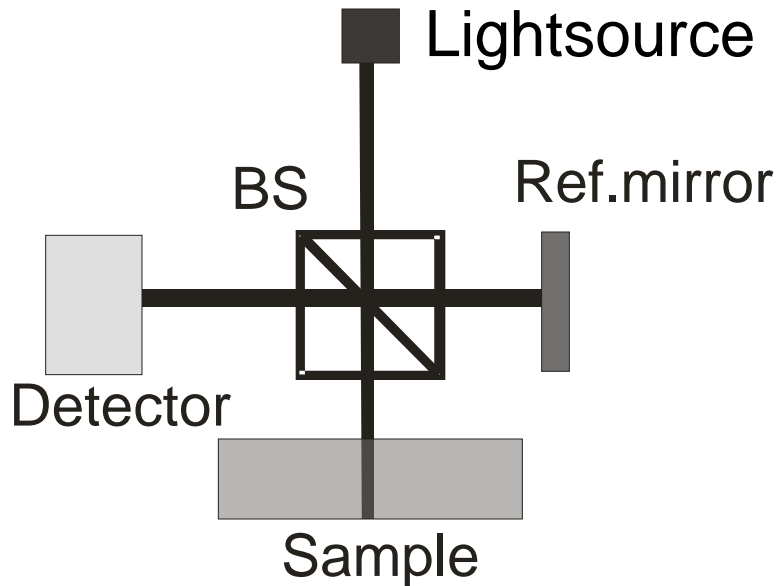
▶ Additional information and contrast: e.g. internal strain

→ **Polarization-sensitive OCT**

▶ On-line inspection: **short measurement times (FD-OCT)**

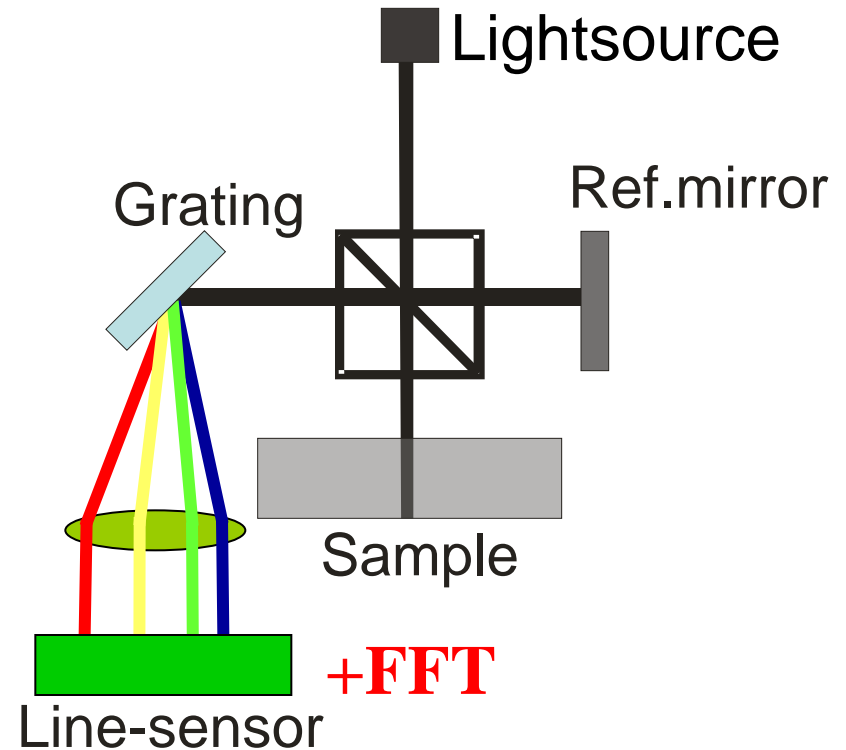
# Time-Domain versus Fourier-Domain (Spectral-Domain (SD))

## Time-Domain



1-1000 A-scans/s

## Spectral-Domain



20.000-100.000 A-scans/s



# Time-Domain versus Fourier-Domain (Spectral-Domain (SD))

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Image-size: 1 Mpxl

Polyolefin foam

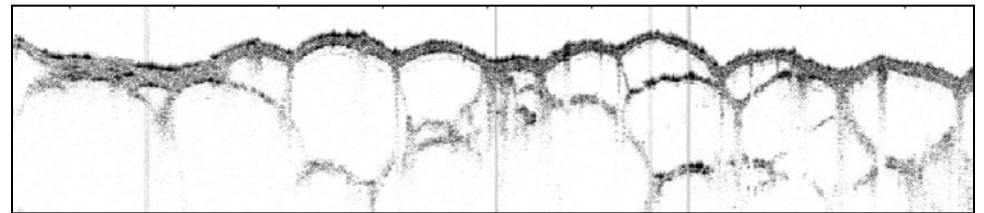
500  $\mu\text{m}$



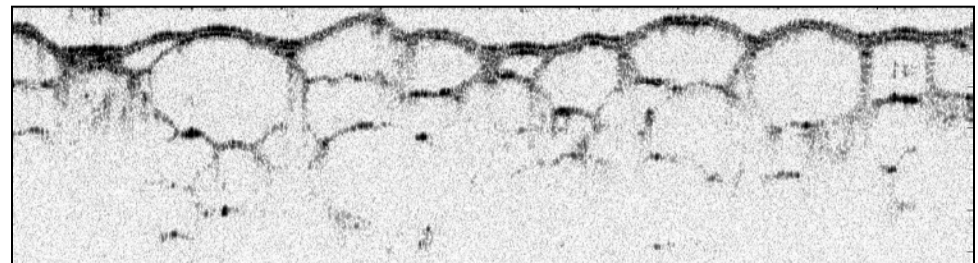
First TD-OCT (with SLD):  
500 seconds



TD-OCT (UHR):  
2 seconds

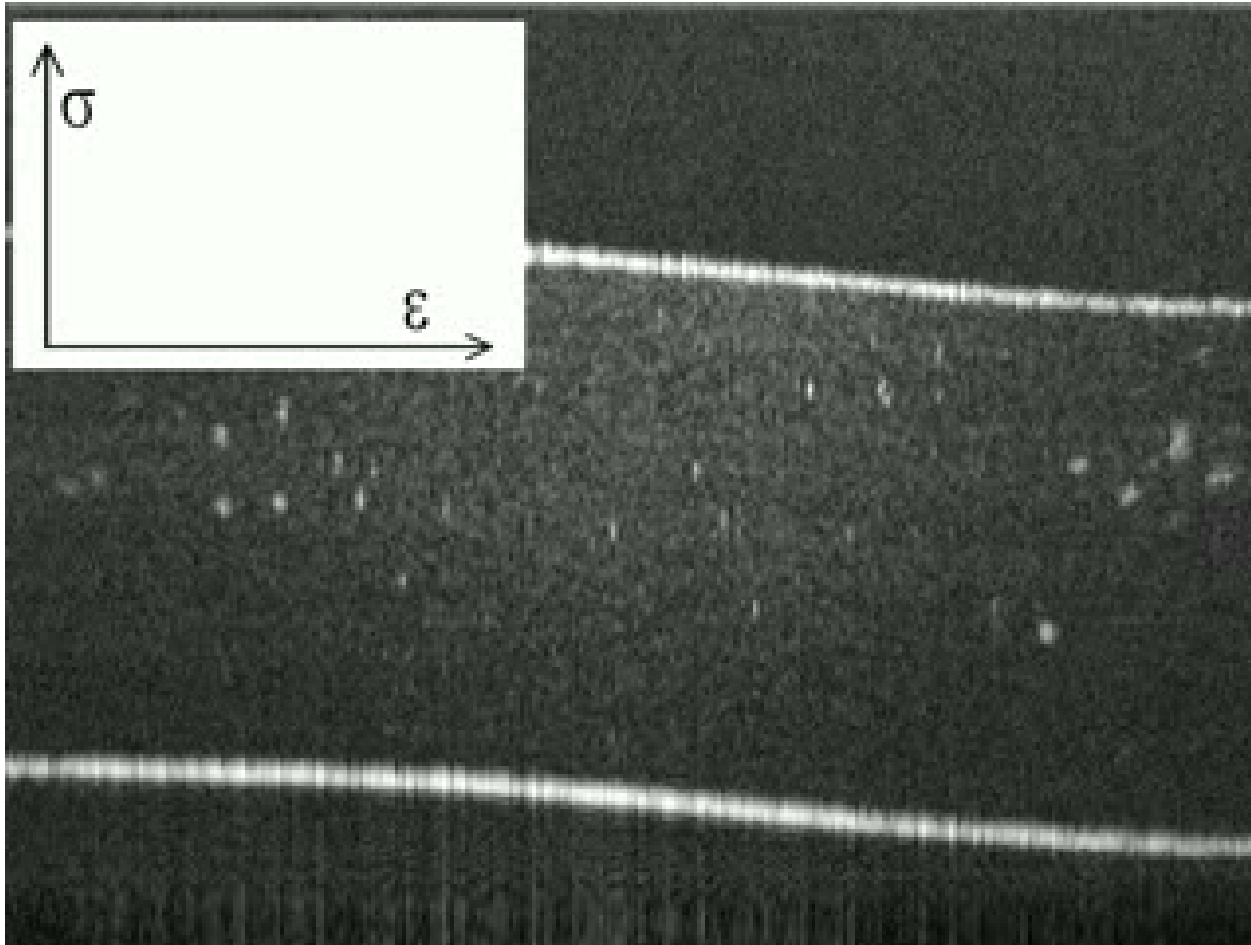


SD-OCT (UHR):  
0.036 seconds



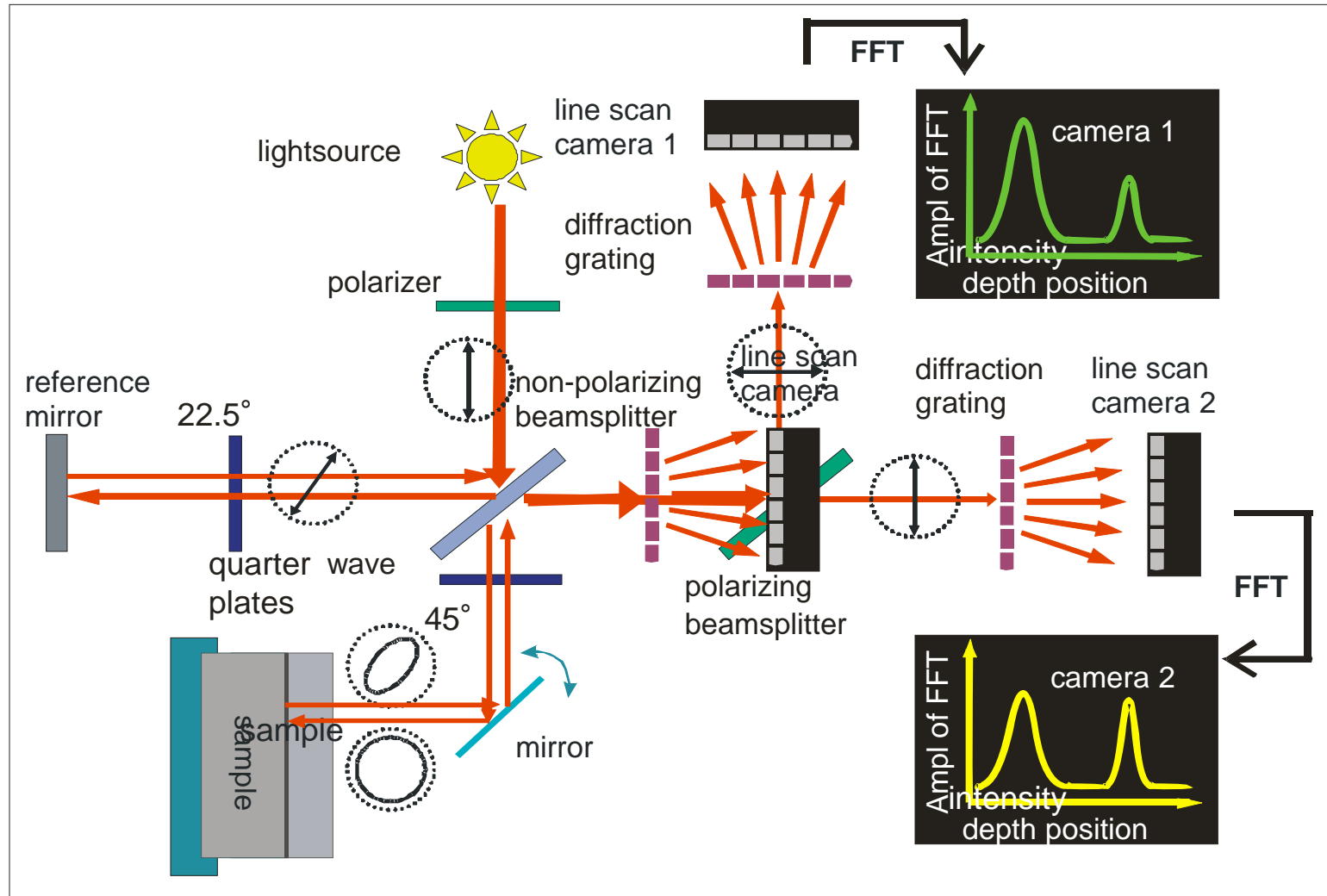
# SD-OCT: tensile testing

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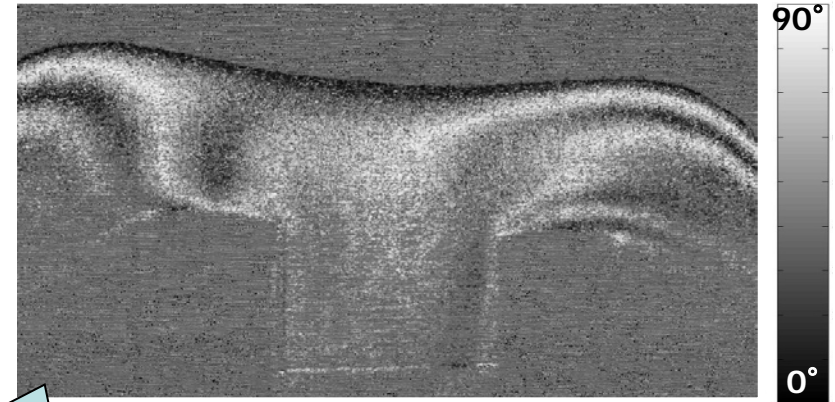
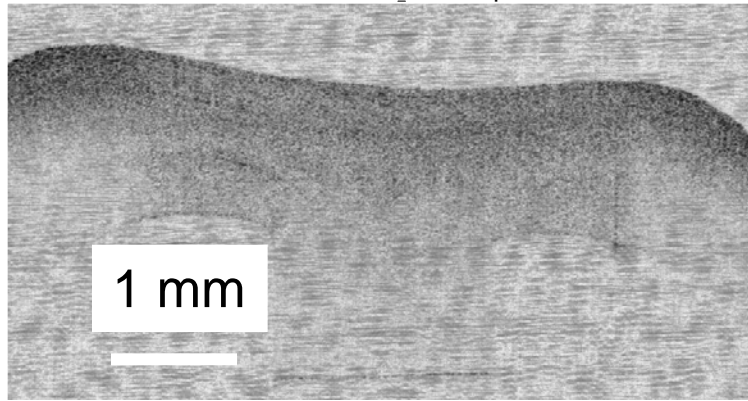


Polypropylene with elastomer particles

# Polarization-sensitive SD-OCT



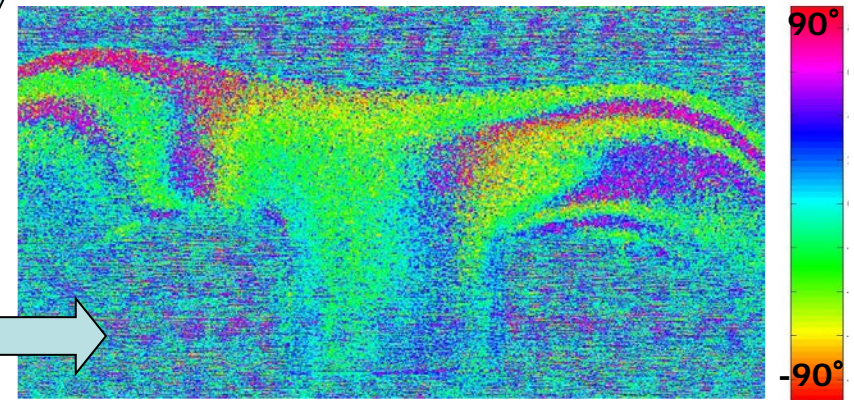
# PS-OCT: 3 images (injection moulded polymer part)



1. Intensity image:  $\sim (A_1^2 + A_2^2)^{1/2}$

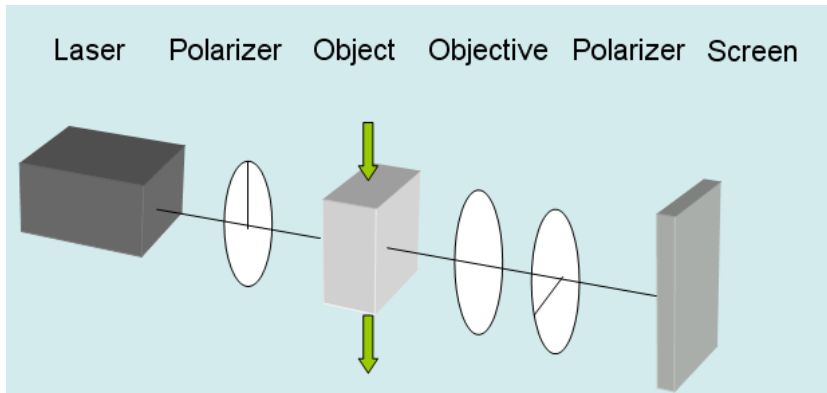
2. Retardation image:  $\sim \text{atan}(A_1 / A_2)$

3. Image of orientation of optical axis:  
 $\sim \phi_1 - \phi_2$

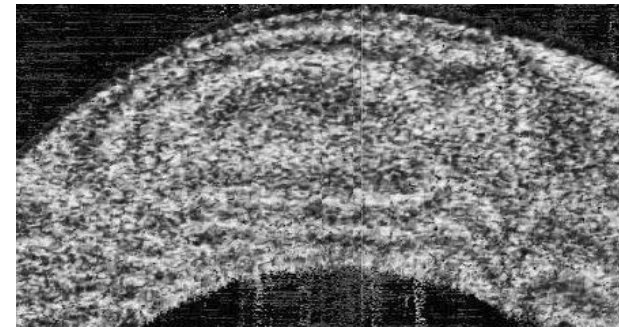
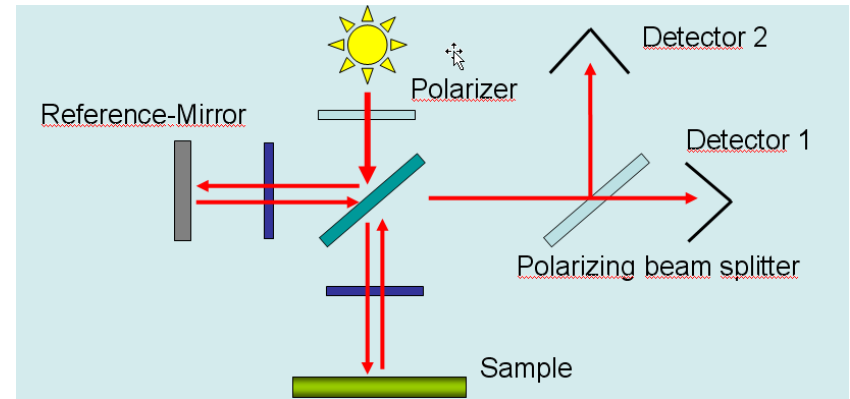


# Stress & Retardation Images

## Photoelasticity

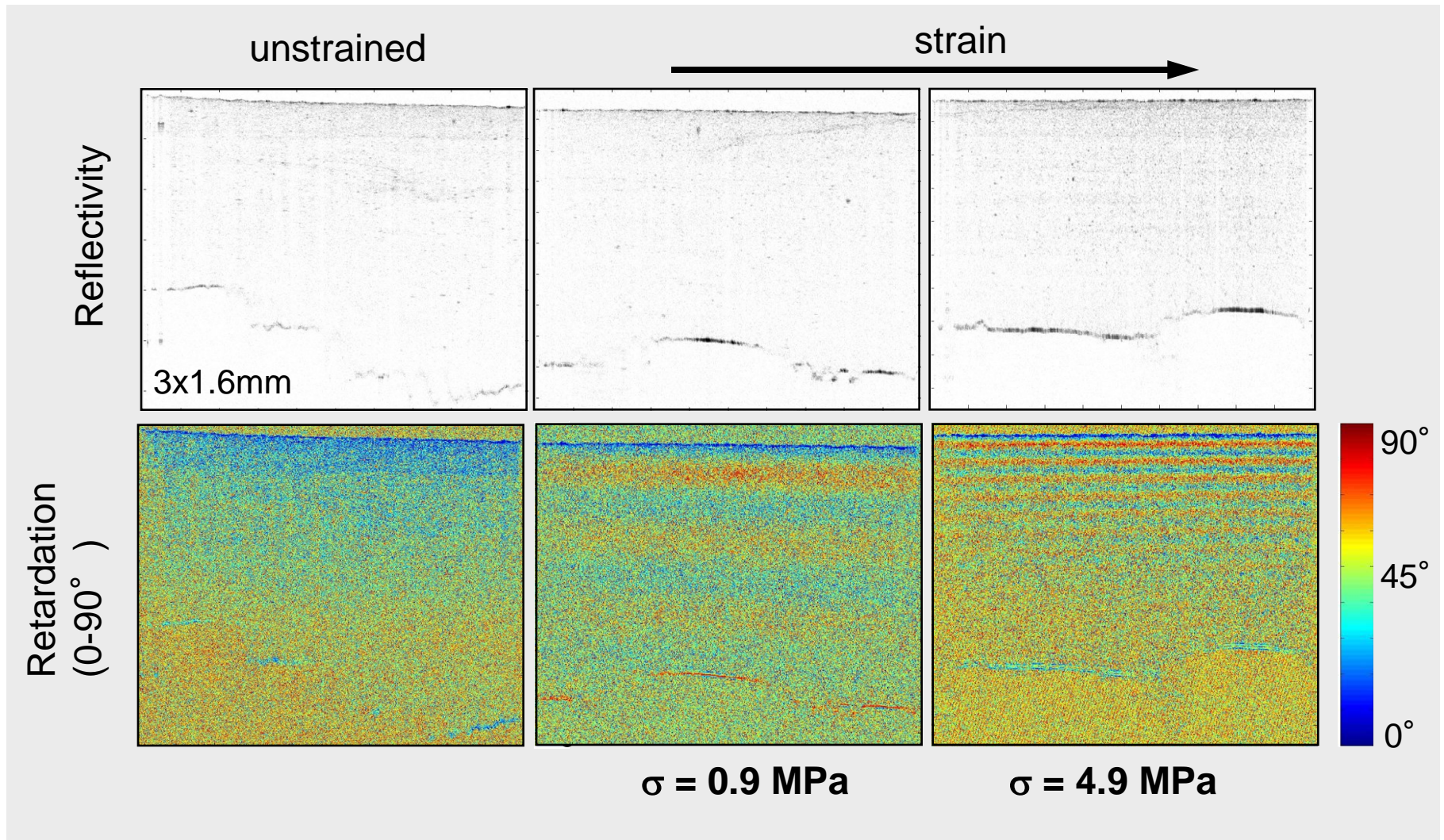


## PS-OCT

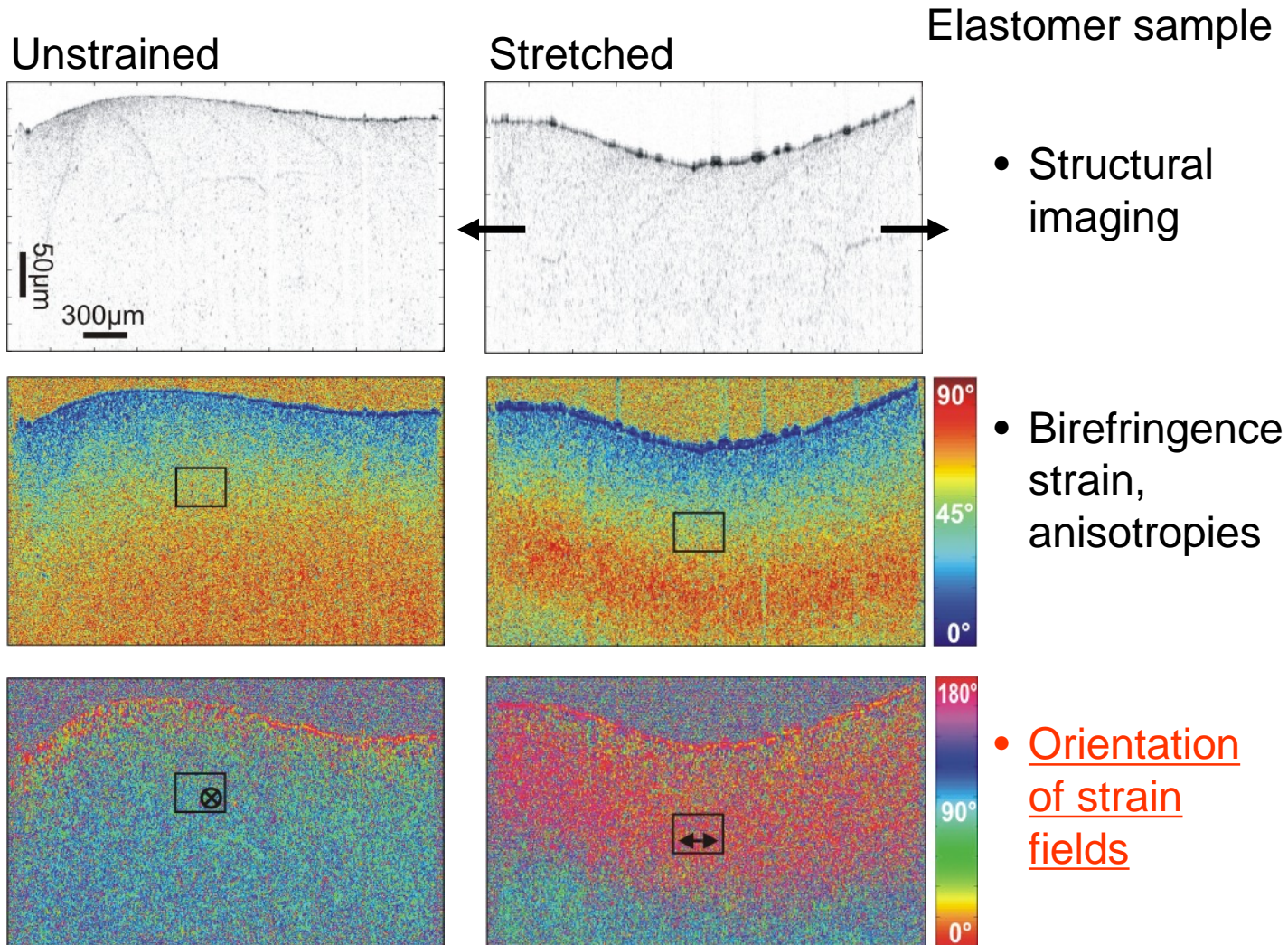


*Bended polymer structure imaged by PS-OCT (Retardation image)*

# PS-OCT: strain/stress - birefringence

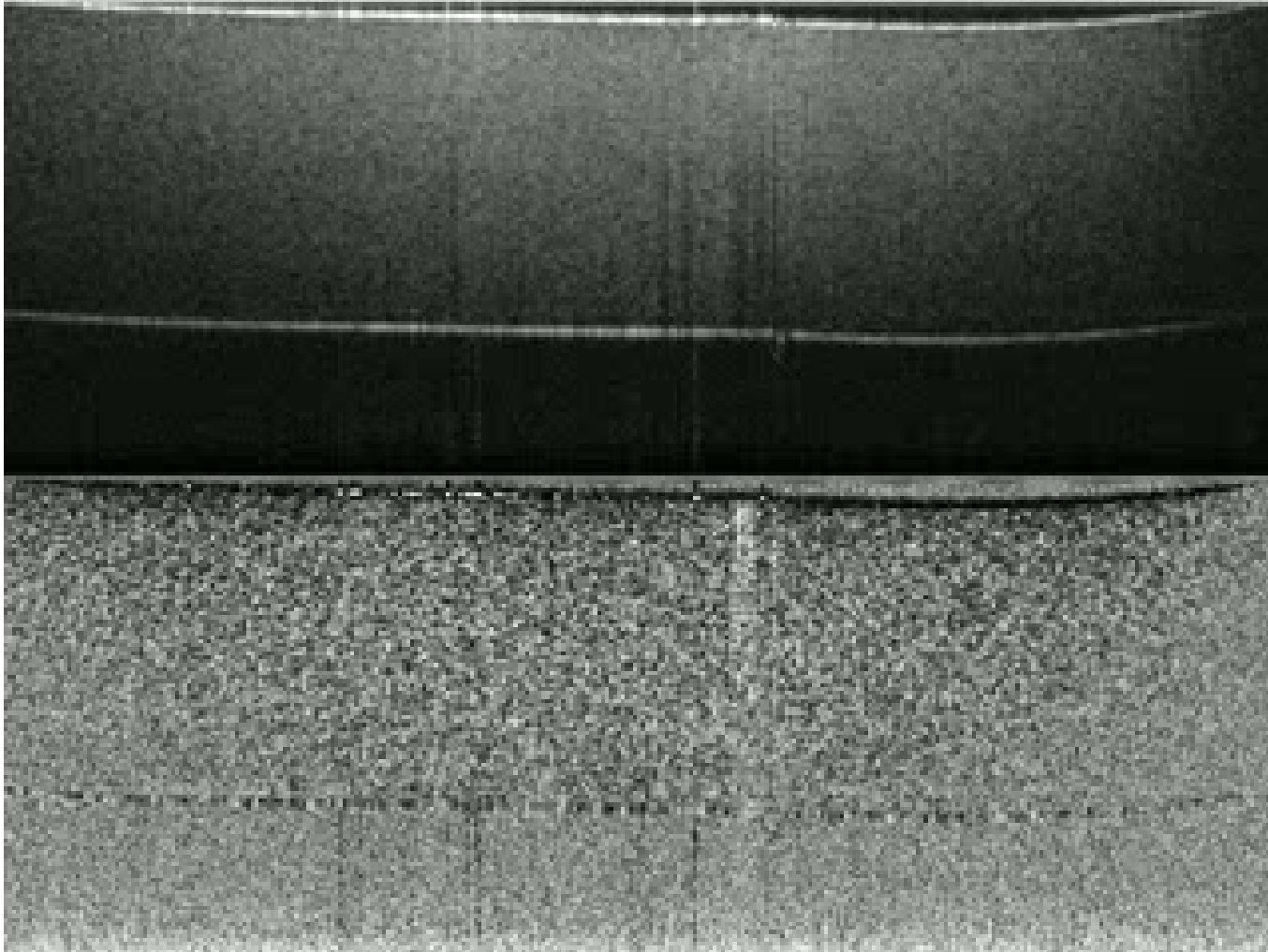


# PS-OCT: orientation of optical axis



# SD-PS-OCT: tensile testing (external defect)

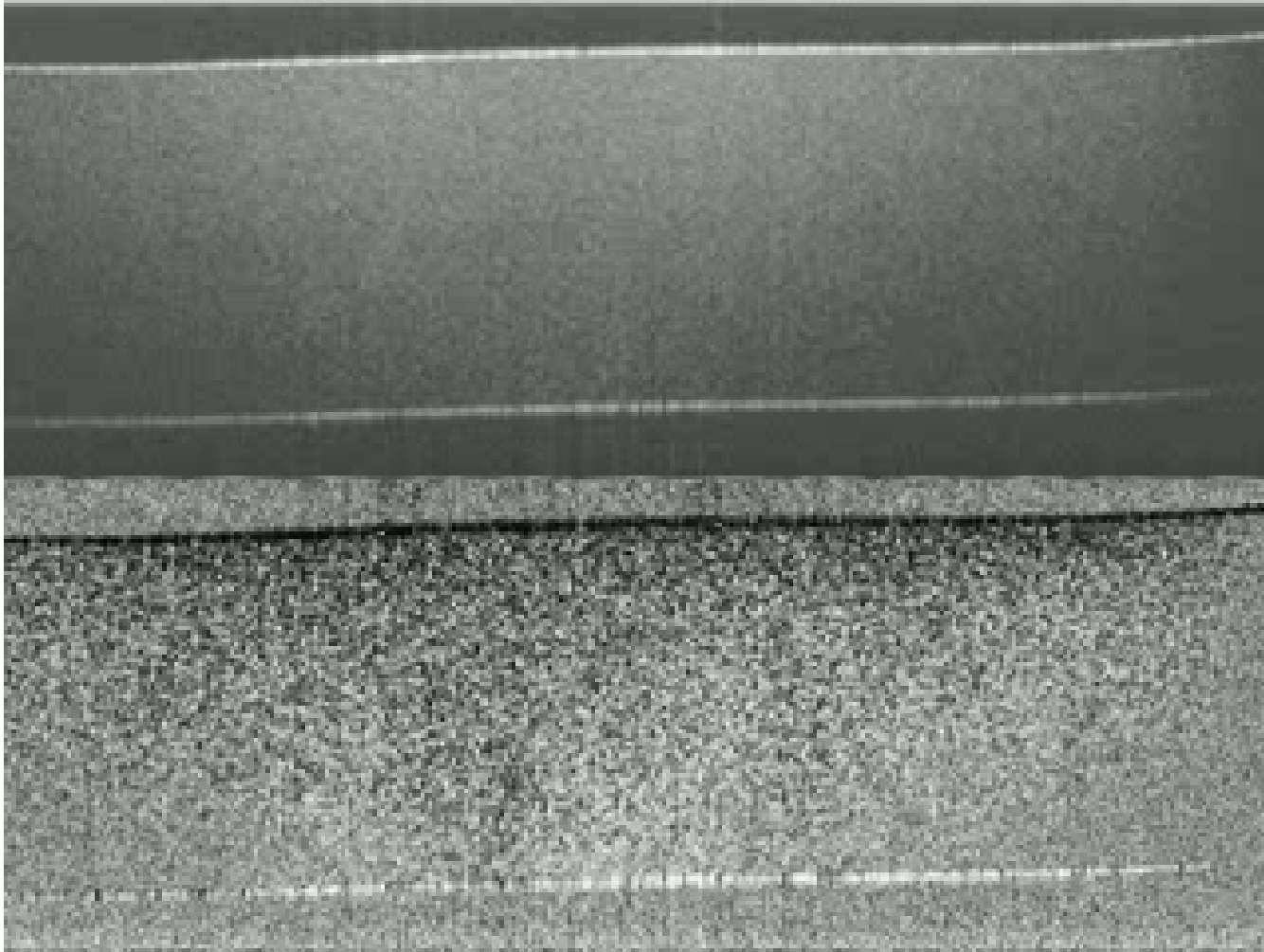
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# SD-PS-OCT: tensile testing (internal defect)

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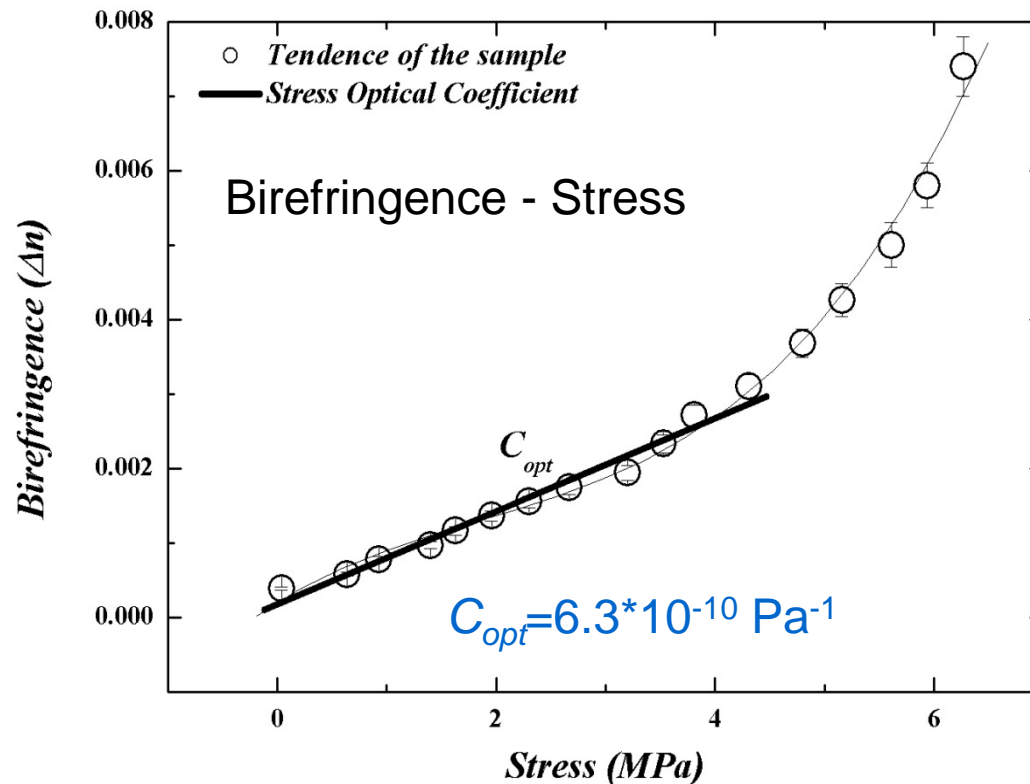
# Quantification: Birefringence calibration

Birefringence  $\Delta n$ :

$$\Delta n = \frac{\lambda}{360} \frac{d(\text{retardation})}{d(\text{depth})}$$

Stress optical coefficient  $C_{opt}$ :

$$C_{opt} = \frac{\Delta n}{\sigma}$$



# 2D-image processing for PS-OCT

## Reconstruction Procedure

### (1) Pre-processing

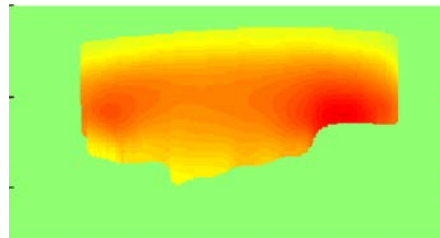
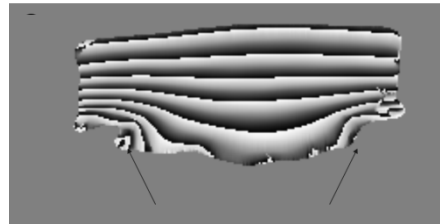
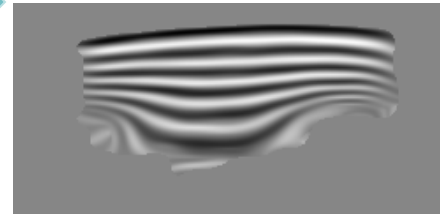
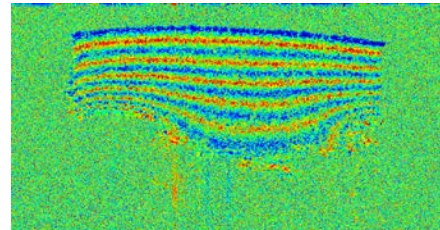
- Median filtering
- CED-based denoising
- Background correction

### (2) Demodulation

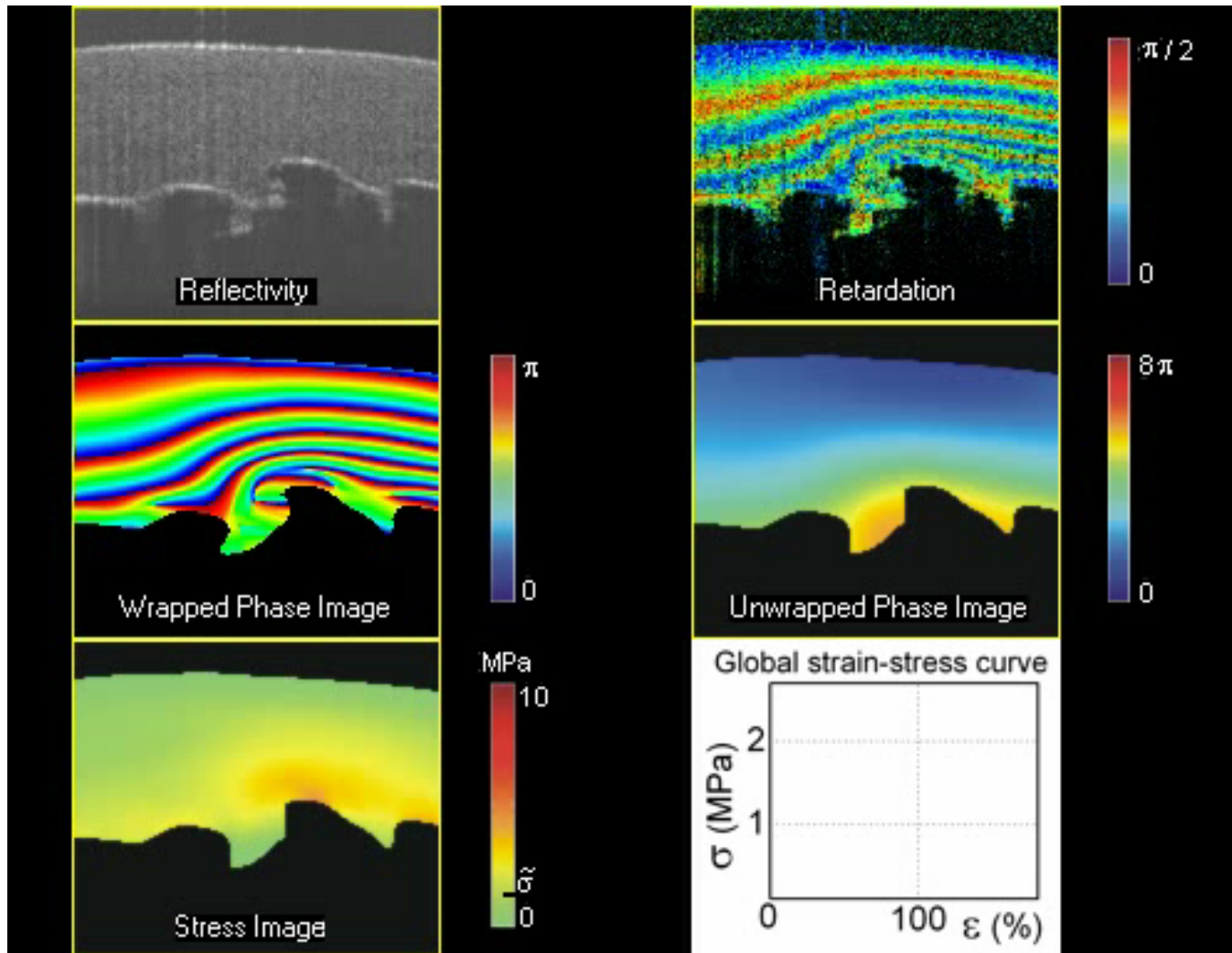
- Quadrature component  
(Radial HT)
- Orientation estimation
- Unwrapping

### (3) Differentiation

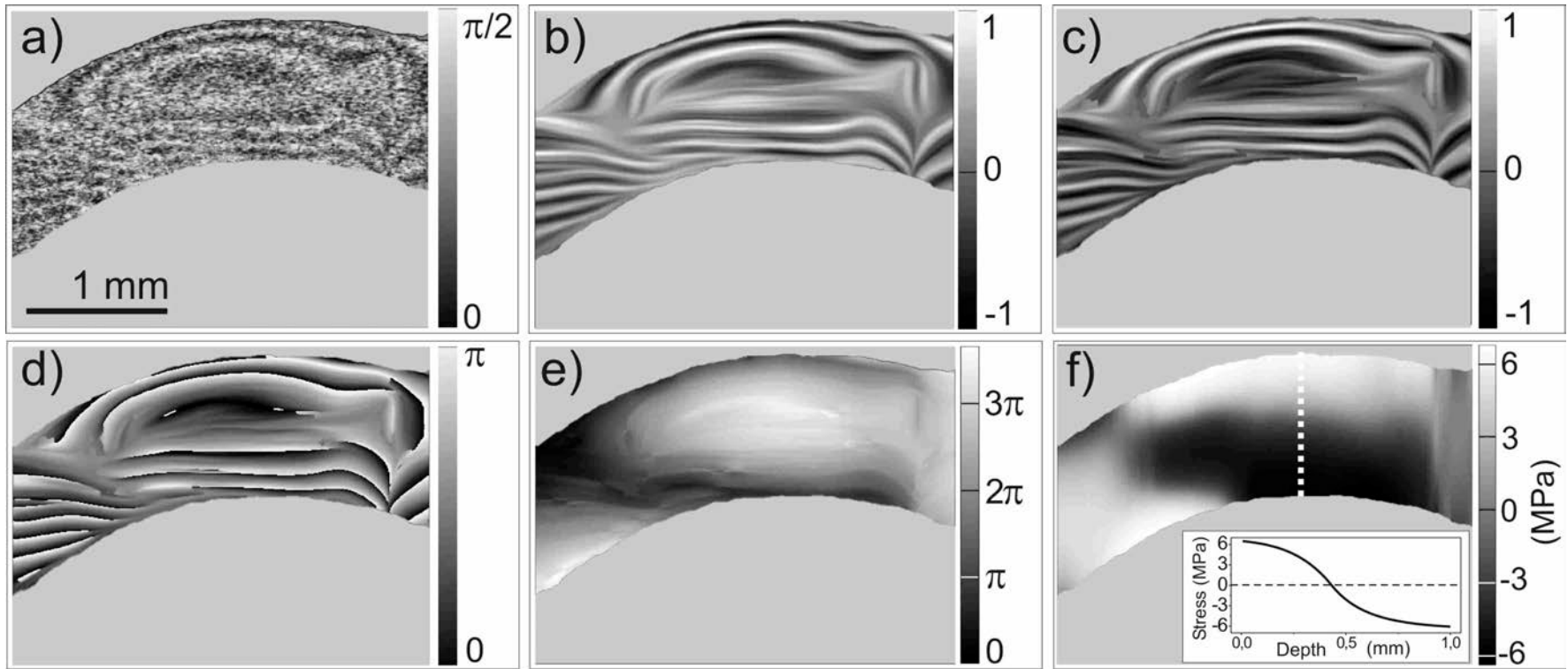
- Numerical differentiation
- Birefringence  $\rightarrow$  Stress



# Quantitative SD-PS-OCT: tensile testing



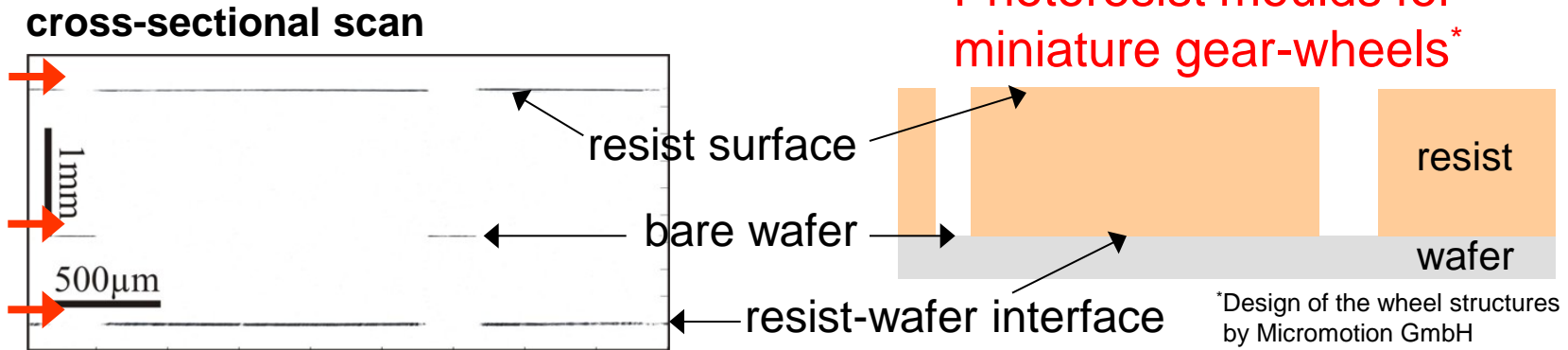
# PS-OCT: bent polymer structure



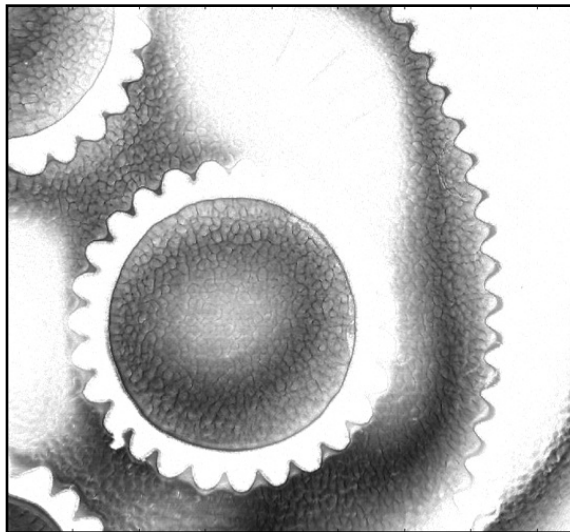
- a) Original retardation image
- b) Denoising: Coherence enhancing diffusion (CED)
- c) Quadrature image
- d) Retardation: wrapped phase
- e) Retardation: unwrapped phase
- f) Stress image

# Surface and interface structures

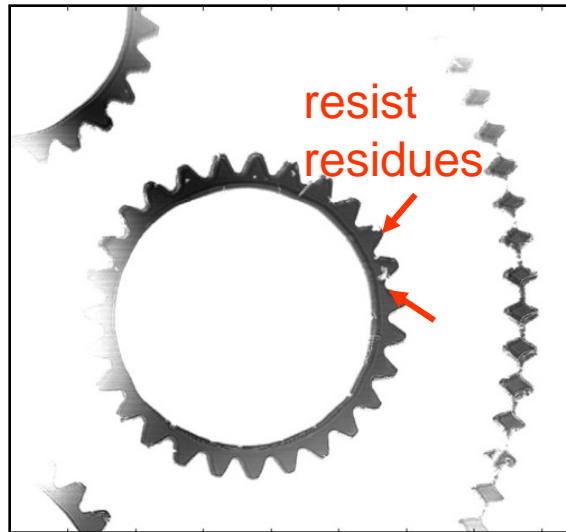
Photoresist moulds for miniature gear-wheels\*



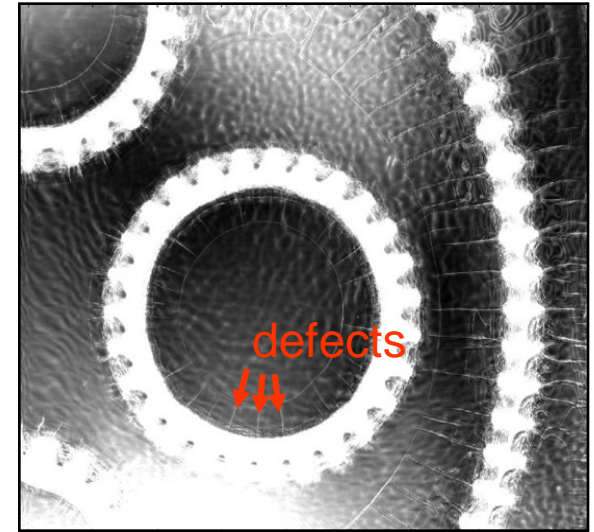
en-face scans ( $\sim 3 \times 3 \text{mm}^2$ )



resist surface

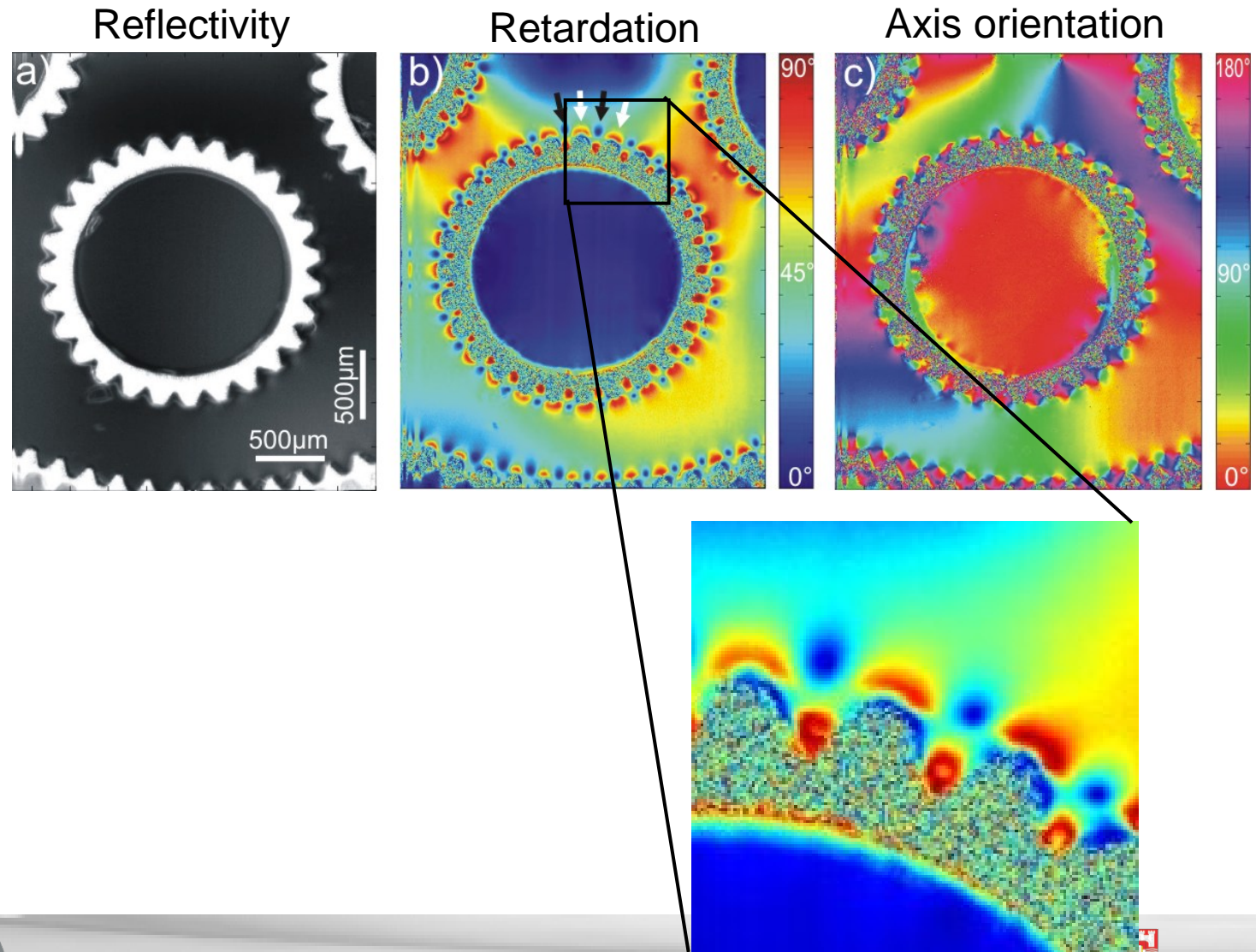


bare wafer

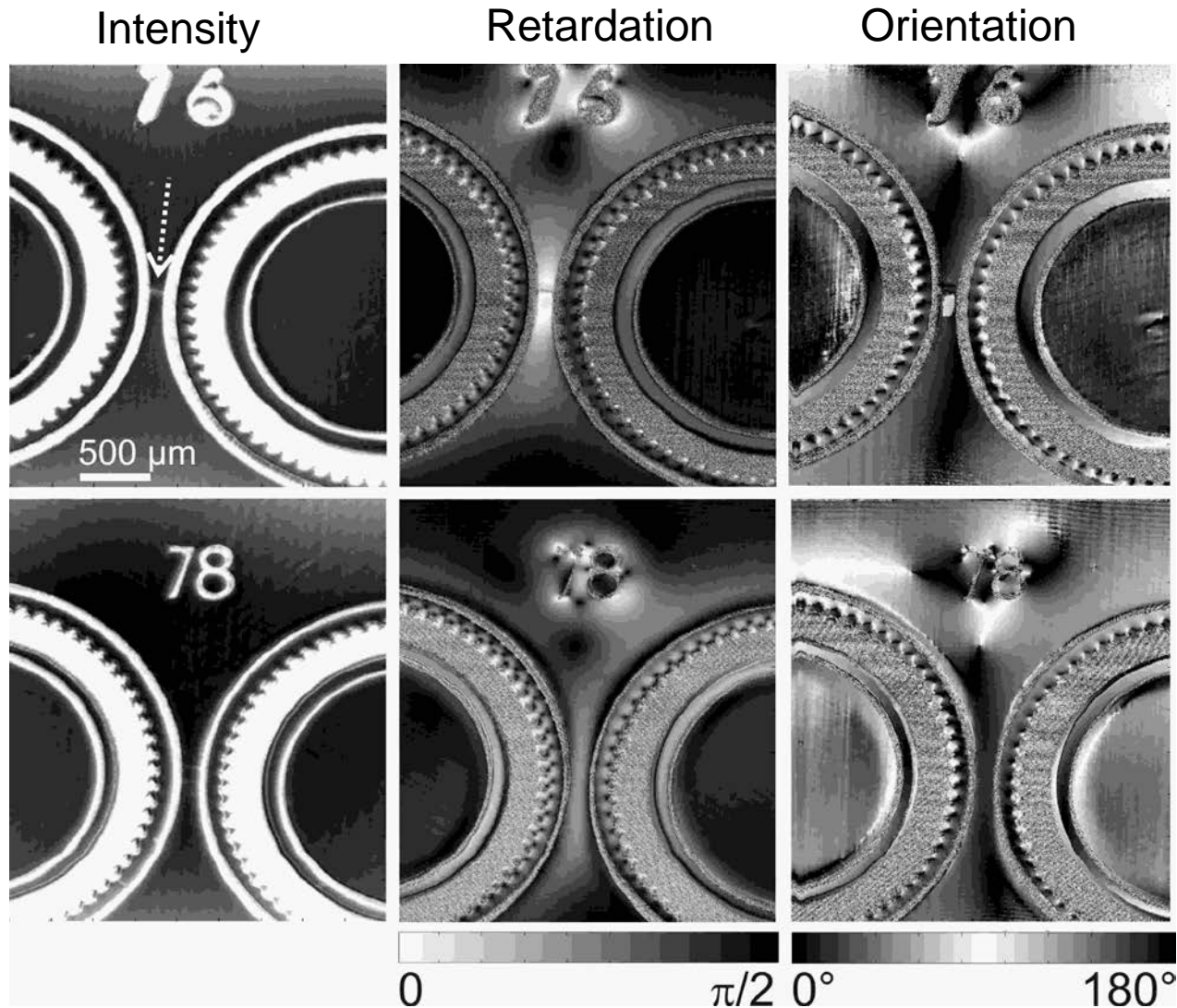


resist-wafer interface

# PS-OCT: strain mapping in micro-photoresist moulds

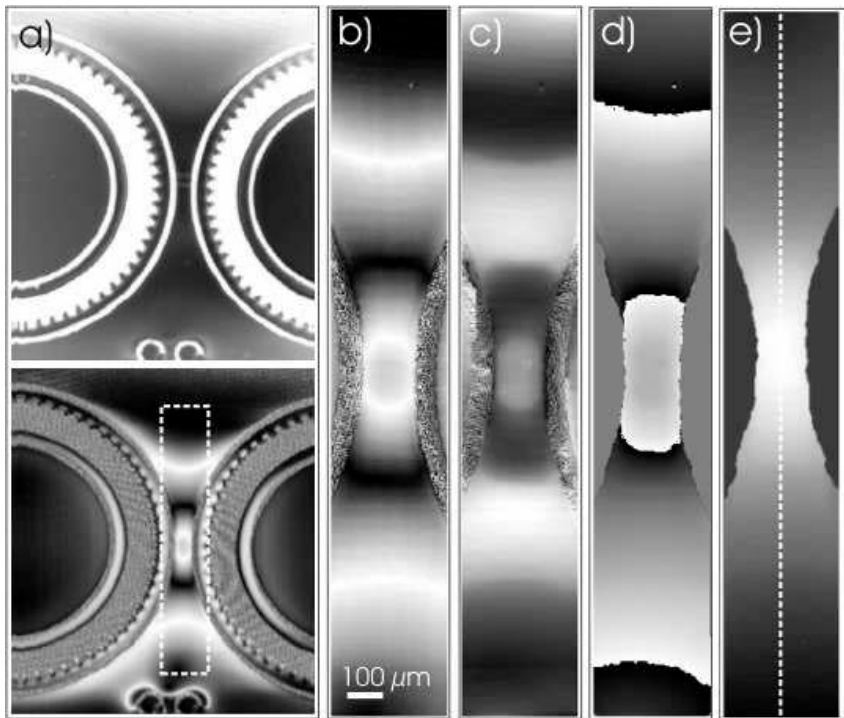


# PS-OCT: process optimisation (minimizing strain)

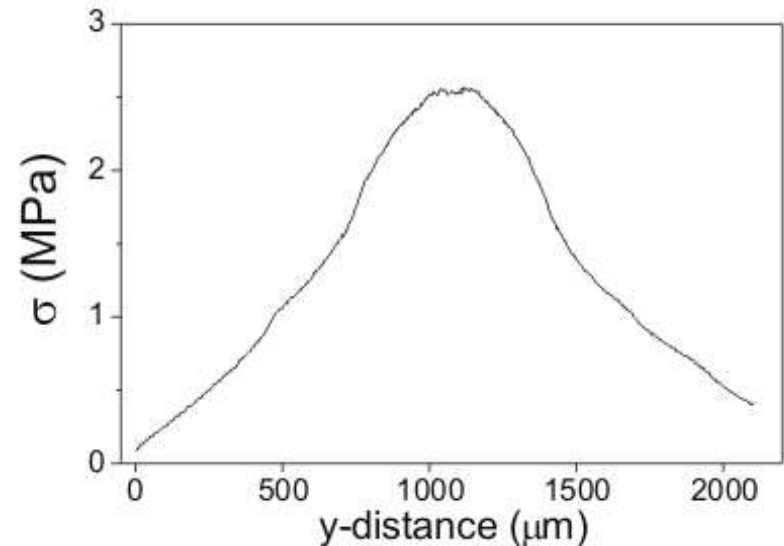
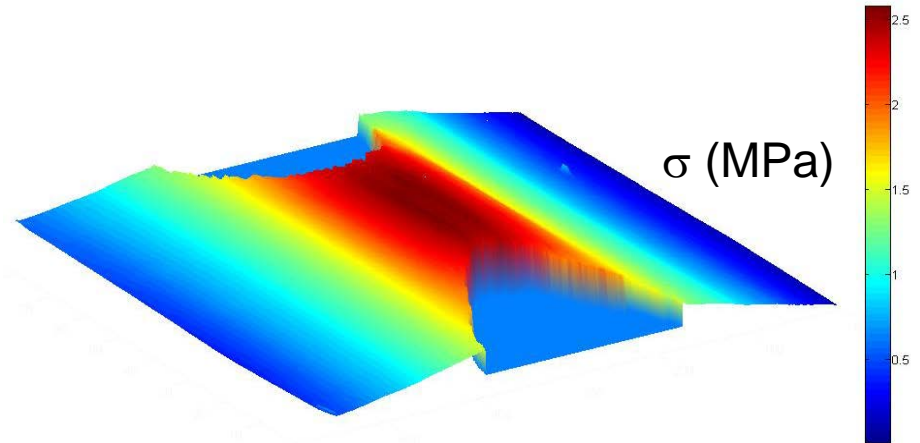




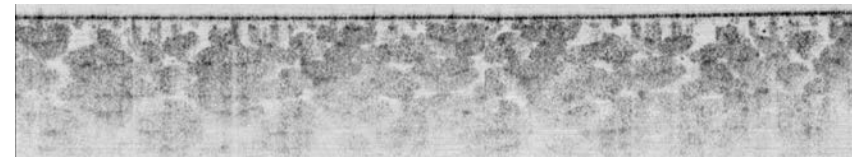
# PS-OCT: stress quantification



- a) Original retardation image
- b) Retardation image: region of interest
- c) Quadrature image
- d) Retardation: wrapped phase
- e) Retardation: unwrapped phase
- f) Stress image



# Observation of damage formation

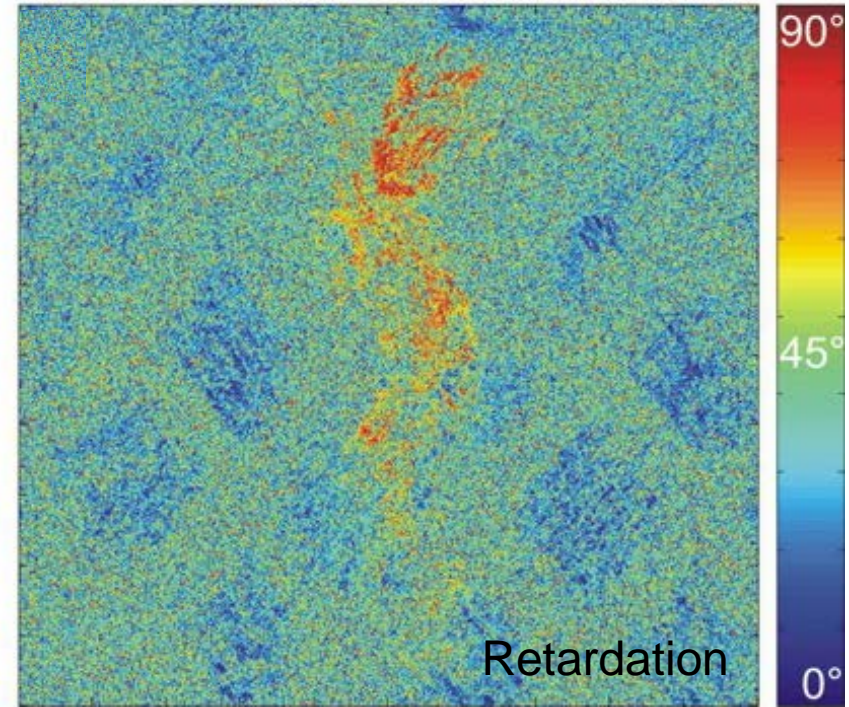
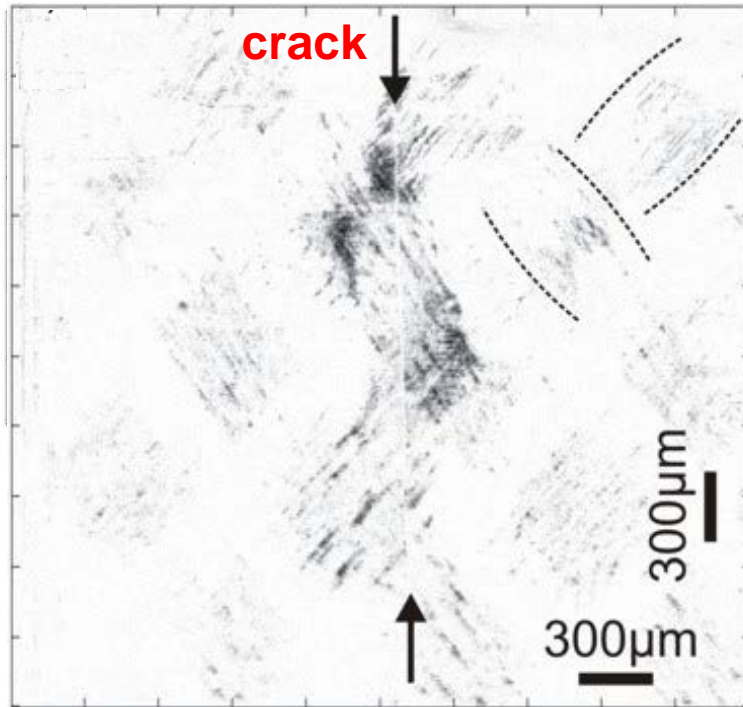


1 mm



# Glass-fibre composites (GFCs)

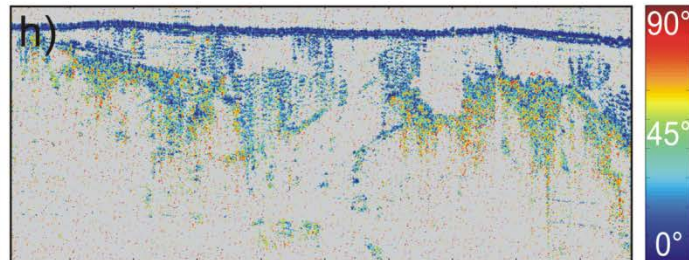
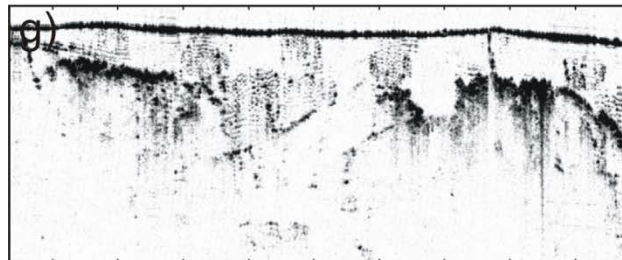
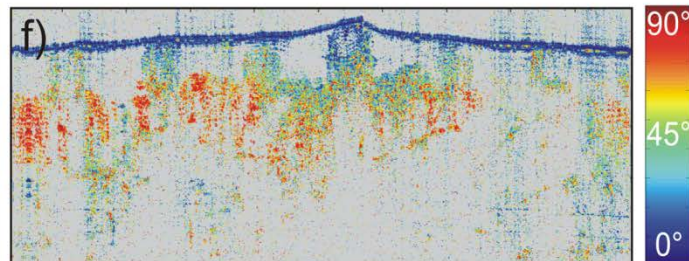
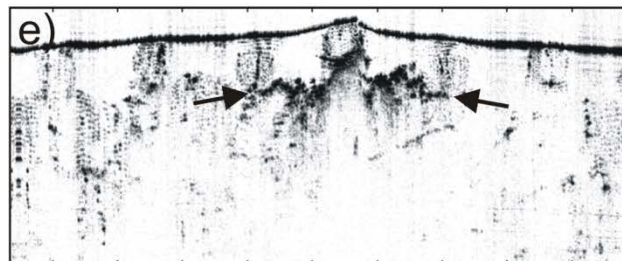
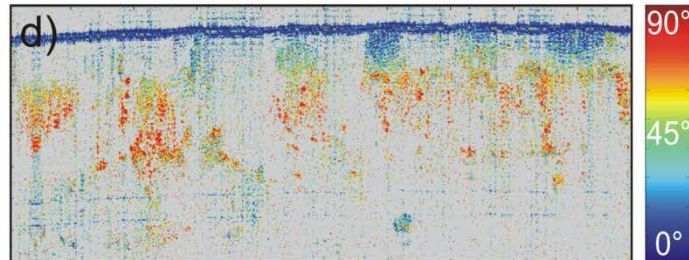
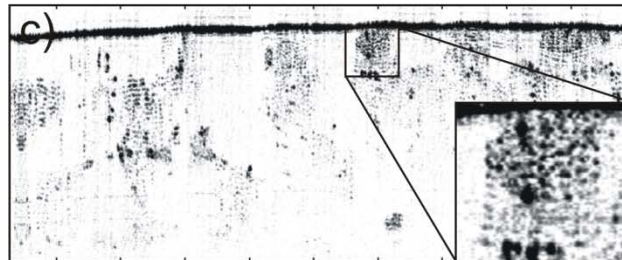
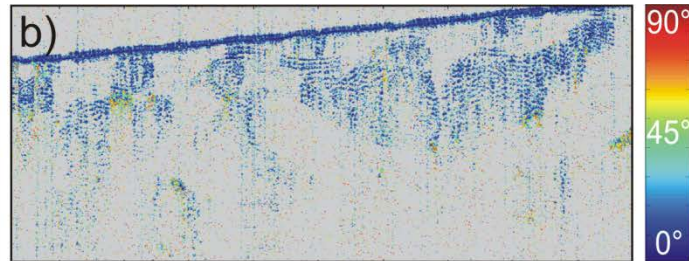
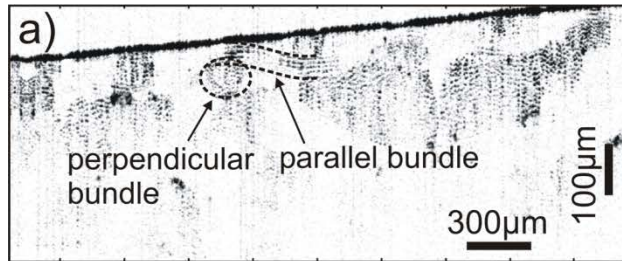
→ **crack-formation** due to loading tests



Increased birefringence in fibre bundles near crack

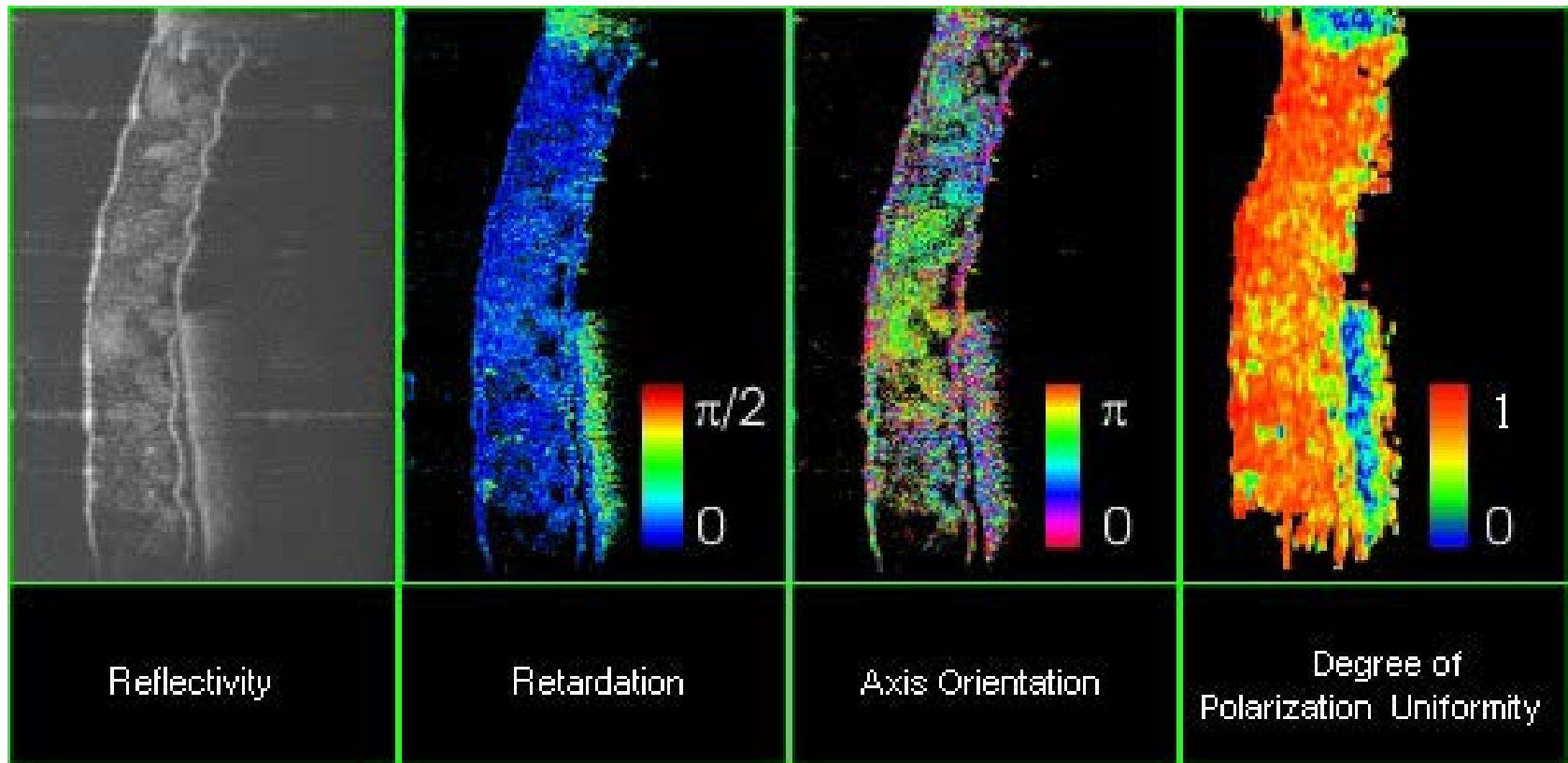
# Glass-fibre composites (GFCs)

Increasing stress (bending)



released

# Dynamic fracture test (glass fiber composite)



# Conclusion

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- Application to different types of materials and parts:
  - Bulk polymer parts, fibre composite materials, laminates and multilayer systems,...
- PS imaging for
  - PS – additional contrast
  - Depth resolved strain/stress – mapping
- SD-OCT for
  - High-speed imaging
- in progress:
  - Improvement of quantification